**FCC ID: YJW62456AU**

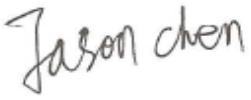
Portable device
According to §15.247(e)(i) and §1.1307(b)(1), systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy level in excess of the Commission's guidelines.
According to KDB447498 D01 General RF Exposure Guidance V06
The 1-g SAR and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:
[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)]·[√f(GHZ)] ≤ 3.0 for 1-g SAR and ≤ 7.5 for 10-g extremity SAR, where:

- f(GHZ) is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison

When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.
BLE:

| Modulation | Channel Freq. (GHz) | Conducted power (dBm) | Conducted power (mW) | Tune-up power (dBm) | Max tune-up power (dBm) | Max tune-up power (mW) | Distance (mm) | Result calculation | SAR Exclusion threshold | SAR test exclusion |
|---|---|---|---|---|---|---|---|---|---|---|
| GFSK | 2.402 | 2.31 | 1.70 | 2±1 | 3 | 2.00 | <5 | 0.61847 | 3.00 | YES |
| | 2.44 | 1.94 | 1.56 | 2±1 | 3 | 2.00 | <5 | 0.62334 | 3.00 | YES |
| | 2.480 | 1.67 | 1.47 | 2±1 | 3 | 2.00 | <5 | 0.62843 | 3.00 | YES |
| π/4-DQPSK | 2.402 | 2.75 | 1.88 | 2±1 | 3 | 2.00 | <5 | 0.61847 | 3.00 | YES |
| | 2.44 | 2.54 | 1.79 | 2±1 | 3 | 2.00 | <5 | 0.62334 | 3.00 | YES |
| | 2.480 | 2.58 | 1.81 | 2±1 | 3 | 2.00 | <5 | 0.62843 | 3.00 | YES |
| 8-DPSK | 2.402 | 2.8 | 1.91 | 2±1 | 3 | 2.00 | <5 | 0.61847 | 3.00 | YES |
| | 2.44 | 2.62 | 1.83 | 2±1 | 3 | 2.00 | <5 | 0.62334 | 3.00 | YES |
| | 2.480 | 2.73 | 1.87 | 2±1 | 3 | 2.00 | <5 | 0.62843 | 3.00 | YES |

**Conclusion:**
For the max result : 0.62843W/Kg ≤ 3.0 for 1g SAR, No SAR is required.



**Signature:** **Date:** 2018-06-7

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